

**Search Notes**

Application/Control No.

10/605,653

Examiner

Jason M. Han

Applicant(s)/Patent under  
Reexamination

YU ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	29-30	2/17/2006	JMH
362	97	2/17/2006	JMH
349	61-69	2/17/2006	JMH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	2/17/2006	JMH